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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/772,078	02/03/2004	Toshifumi Masaki	1232-5273	4536
	7590 07/07/200 INNEGAN, L.L.P.		EXAMINER	
3 WORLD FIN	ANCIAL CENTER		STULTZ, JESSICA T	
NEW YORK, N	NY 10281-2101		ART UNIT	PAPER NUMBER
			2873	
			NOTIFICATION DATE	DELIVERY MODE
			07/07/2008	ELECTRONIC

# Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

Notice of the Office communication was sent electronically on above-indicated "Notification Date" to the following e-mail address(es):

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	Application No.	Applicant(s)	
	10/772,078	MASAKI, TOSHIFUMI	
Office Action Summary	Examiner	Art Unit	
	Jessica T. Stultz	2873	
The MAILING DATE of this communication ap Period for Reply	pears on the cover sheet with the o	correspondence address	
A SHORTENED STATUTORY PERIOD FOR REPL WHICHEVER IS LONGER, FROM THE MAILING D.  - Extensions of time may be available under the provisions of 37 CFR 1. after SIX (6) MONTHS from the mailing date of this communication.  - If NO period for reply is specified above, the maximum statutory period.  - Failure to reply within the set or extended period for reply will, by statut Any reply received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b).	DATE OF THIS COMMUNICATION 136(a). In no event, however, may a reply be tir will apply and will expire SIX (6) MONTHS from e, cause the application to become ABANDONE	N. mely filed the mailing date of this communication. ED (35 U.S.C. § 133).	
Status			
Responsive to communication(s) filed on 28 A     This action is <b>FINAL</b> . 2b) ☑ This     Since this application is in condition for allowed closed in accordance with the practice under	s action is non-final. ance except for formal matters, pro		
Disposition of Claims			
4) Claim(s) 1,4,5,8,9 and 14 is/are pending in the 4a) Of the above claim(s) 4,5,8 and 9 is/are w  5) Claim(s) is/are allowed. 6) Claim(s) 1 and 14 is/are rejected. 7) Claim(s) is/are objected to. 8) Claim(s) are subject to restriction and/o	ithdrawn from consideration.  or election requirement.		
10) ☐ The drawing(s) filed on <u>03 February 2004</u> is/al Applicant may not request that any objection to the Replacement drawing sheet(s) including the correct 11) ☐ The oath or declaration is objected to by the E	re: a)⊠ accepted or b)⊡ objecte e drawing(s) be held in abeyance. Section is required if the drawing(s) is ob	e 37 CFR 1.85(a). jected to. See 37 CFR 1.121(d).	
Priority under 35 U.S.C. § 119			
<ul> <li>12) Acknowledgment is made of a claim for foreign a) All b) Some * c) None of:</li> <li>1. Certified copies of the priority document 2. Certified copies of the priority document 3. Copies of the certified copies of the priority application from the International Bureat*</li> <li>* See the attached detailed Office action for a list</li> </ul>	nts have been received. Its have been received in Applicat Pority documents have been receive Bu (PCT Rule 17.2(a)).	ion No ed in this National Stage	
Attachment(s)  1) Notice of References Cited (PTO-892)  2) Notice of Draftsperson's Patent Drawing Review (PTO-948)  3) Information Disclosure Statement(s) (PTO/SB/08)  Paper No(s)/Mail Date	4) Interview Summary Paper No(s)/Mail D 5) Notice of Informal F 6) Other:	ate	

### DETAILED ACTION

### Election/Restrictions

This application contains claims 4-5 and 8-9 drawn to an invention nonelected with traverse in the reply filed on May 8, 2007. A complete reply to this non-final rejection must include cancellation of nonelected claims or other appropriate action (37 CFR 1.144) See MPEP § 821.01.

### Claim Rejections - 35 USC § 102

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless –

(b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.

Claims 1 and 14 are rejected under 35 U.S.C. 102(b) as being anticipated by Fujieda US 5,889,576, herein referred to as Fujieda '576.

Regarding claim 1, Fujieda '576 discloses an ophthalmologic apparatus (Abstract) comprising: an eye examining portion unit for receiving a light beam and effecting the measurement of the eye to be examined (Column 6, line 55-Column 7, line 41, wherein a light beam from light sources "11" reaches the fundus of the eye as shown in Figures 2 and 4-5); an image pickup element for picking up the image of the front eye part of the eye to be examined (Column 6, line 55-Column 7, line 41, wherein the image pickup element comprises image forming lens "26", as shown in Figures 2 and 4-5); and a controller for determining whether an eyelid of the eye covers a pupil of the eye by comparing pupil diameter of the eye obtained from the image part of the eye with a predetermined value (Column 5, line 43-Column 6, line 54 and

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Column 7, line 49-Column 8, line 45, wherein the pupil diameter is detected and compared to a rectangular area "110", specifically, Column 5, lines 57-61, wherein pupils of large diameter are partially covered by an upper eyelid, Figures 4-7), for detecting the positional shift between a position of the vertex of the cornea and the eye examining portion unit instead of detecting the positional shift between the center of the pupil of the eye to be examined and the eye examining portion unit in a case where the pupil diameter of the eye to be examined is larger than the predetermined value (Column 5, lines 58-61 and Column 6, lines 5-11 and 44-46, and Column 8, lines 13-40, specifically wherein when the pupil diameter is greater than the area "110", which includes when the pupil diameter is large and the pupil is partially covered by an upper eyelid, a shift between the corneal vertex "101" and the eye examining portion is determined, Figures 4-5), for detecting the positional shift between the center of the pupil of the eye to be examined and the eye examining portion unit in a case where the controller does not determined that the eyelid of the eye covers the pupil of the eye (Column 6, lines 47-54 and Column 8, lines 3-11 and 40-45, wherein when the pupil diameter is smaller than the area "110", and thereby an eyelid of the eye inherently does not cover the pupil, a shift between the pupil center "111" and the eye examining portion is determined, Figures 4-5), and for aligning the eye examining portion unit based on the detected positional shift (Column 5, line 43-Column 6, line 54 and Column 7, line 49-Column 8, line 45, wherein the eye examining portion is aligned based on the positional shift).

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Regarding claim 14, Fujieda '576 further discloses that the controller determines the pupil diameter of the eye to be examined on the basis of an edge of the pupil in a horizontal direction and an edge of an iris in the horizontal direction (Column 4, line 54-Column 6, line 54,

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wherein the pupil diameter is determined to be larger or smaller than area "110" using an edge of the pupil that meets an edge of the iris in the horizontal direction, as shown in Figures 4-5).

# Response to Arguments

Applicant's arguments filed April 28, 2008 have been fully considered but they are not persuasive. Specifically, applicant argues that the Fujieda et al '172 reference does not disclose a controller for determining whether an eyelid of the eye covers a pupil of the eye and detecting positional shift as claimed. However, the examiner disagrees since Fujieda et al '172 discloses an apparatus that detects the positional shift in different manners based on whether the pupil diameter is larger or smaller than area "110" (Column 5, lines 58-61 and Column 6, lines 44-54) and also whether or not an eyelid would cover at least partially the pupil (Column 5, liens 58-61) or not (Column 6, lines 50-54, wherein a pupil having a diameter less than the area "110" inherently would not be partially covered by an eyelid). Furthermore, Fujieda et al '172 discloses an apparatus for detecting the positional shift between a position of the vertex of the cornea and the eye examining portion unit instead of detecting the positional shift between the center of the pupil of the eye to be examined and the eye examining portion unit in a case where the pupil diameter of the eye to be examined is larger than the predetermined value (Column 5, lines 58-61 and Column 6, lines 5-11 and 44-46, and Column 8, lines 13-40, specifically wherein when the pupil diameter is greater than the area "110", which includes when the pupil diameter is large and the pupil is partially covered by an upper eyelid, a shift between the corneal vertex "101" and the eye examining portion is determined, Figures 4-5), for detecting the positional shift between the center of the pupil of the eye to be examined and the eye examining portion unit in a case where the controller does not determined that the eyelid of the eye covers the pupil of the

eye (Column 6, lines 47-54 and Column 8, lines 3-11 and 40-45, wherein when the pupil diameter is smaller than the area "110", and thereby an eyelid of the eye inherently does not cover the pupil, a shift between the pupil center "111" and the eye examining portion is determined, Figures 4-5).

Applicant also argues that Fujieda et al '172 discloses always using both the corneal vertex and pupil center to detect positional shift. The examiner disagrees that both the corneal vertex and pupil center are always used to detect positional shift, since Fujieda et al '172 discloses using only corneal vertex (Column 6, lines 5-11 and Column 8, lines 13-40) and using only the pupil center (Column 6, lines 46-54 and Column 8, lines 3-11 and 40-45).

### Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Jessica T. Stultz whose telephone number is (571) 272-2339. The examiner can normally be reached on M-F 8-4:30.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Ricky Mack can be reached on 571-272-2333. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

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Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated

information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

Jessica T Stultz Primary Examiner Art Unit 2873

/Jessica T Stultz/ Primary Examiner, Art Unit 2873